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Attorney's Docket No.: 12406-059US2 / 1998P1821 US2 N



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Volker Haerle Art Unit: 2824

Serial No.: 10/625,118 Examiner: Beth E. Owens

Filed : July 22, 2003

Title : METHOD OF PRODUCTION OF SEMICONDUCTOR COMPONENTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. I, the undersigned, hereby certify that each item of information contained in this statement was cited in a communication from a foreign patent office in a counterpart foreign application, the communication being dated March 19, 2004, which is not more than three months prior to the filing of this statement.

No fee is believed to be due. If, however, there are any charges or credits, please apply them to Deposit Account No. 06-1050.

Respectfully submitted,

Fish & Richardson P.C.

500 Arguello Street, Suite 500

Redwood City, California 94063 Telephone: (650) 839-5070

Facsimile: (650) 839-5071

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I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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Substitute Form PTO-1449

next communication to applicant.

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 12406-059US2

Application No. 10/625,118

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Applicant Volker Haerle

Filing Date

Group Art Unit

(37 CFR §1.98(b))

July 22, 2003 2824

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
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	AF						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Transla	ation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	JP 5006880	01/1993	JР			Abstract	
	AM	JP 5160085	06/1993	JР			Abstract	
	AN	JP 6224153	05/1994	JР			Abstract	
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Other Documents (include Author, Title, Date, and Place of Publication)				
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